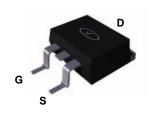


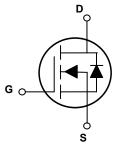


**100V N-Channel MOSFET** 

## **Main Product Characteristics**

V <sub>(BR)DSS</sub>	100V		
R <sub>DS(ON)</sub>	3.1mΩ (max.)		
I <sub>D</sub>	180A		





TO-263 (D2PAK)

**Schematic Diagram** 

#### **Features and Benefits**

- Advanced MOSFET process technology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery



## **Description**

The GSFT3R110 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supplies and a wide variety of other applications.

### **Absolute Maximum Ratings** (T<sub>C</sub>=25°C unless otherwise specified)

Parameter	Symbol	Max.	Unit	
Drain-Source Voltage	V <sub>DS</sub>	100	V	
Gate-Source Voltage	Vgs	±20	V	
Drain Current-Continuous, at Steady-State, (T <sub>C</sub> =25°C) <sup>1</sup>	lp	180	А	
Drain Current-Continuous, at Steady-State, (T <sub>C</sub> =100°C)	טו	128		
Drain Current-Pulsed <sup>2</sup>	Ірм	720	Α	
Single Pulse Avalanche Energy <sup>3</sup>	E <sub>AS</sub>	961	mJ	
Power Dissipation (T <sub>C</sub> =25°C)	Pp	224	W	
Linear Derating Factor (T <sub>C</sub> =25°C)	10	1.8	W/°C	
Junction-to-Ambient (PCB Mounted, Steady-State) <sup>4</sup>	Reja	62.5	°C/W	
Thermal Resistance, Junction-to-Case	Rejc	0.56	°C/W	
Operating Junction Temperature Range	TJ	-55 To +150	°C	
Storage Temperature Range	Тѕтс	-55 To +150	°C	



### **100V N-Channel MOSFET**

## **Electrical Characteristics** (T<sub>C</sub>=25°C unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
On / Off Characteristics						
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	100	-	-	V
Drain-Source Leakage Current	loss	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V	-	-	1	μА
		T <sub>J</sub> =125°C	-	-	20	
Gate-Source Forward Leakage	Igss	V <sub>GS</sub> =20V	-	-	100	nA
		V <sub>GS</sub> =-20V	-	-	-100	
Static Drain-Source On-Resistance	RDS(ON)	V <sub>GS</sub> =10V, I <sub>D</sub> =90A	-	2.4	3.1	mΩ
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{GS}=V_{DS}$ , $I_D=250uA$	2.1	3	3.9	V
Dynamic and Switching Characteris	stics					
Total Gate Charge	Qg	V 50V 1 00A	-	165	-	nC
Gate-Source Charge	Qgs	$V_{DS}$ =50V, $I_{D}$ =90A, $V_{GS}$ =10V	-	61	-	
Gate-Drain ("Miller") Charge	$Q_{gd}$	]	-	40	-	
Turn-On Delay Time	td(on)		-	33	-	nS
Rise Time	tr	$V_{DS}$ =50V, $R_{GEN}$ =3 $\Omega$ ,	-	46	-	
Turn-Off Delay Time	td(off)	$V_{GS}$ =10V, $I_D$ =90A	-	119	-	
Fall Time	<b>t</b> f	]	-	44	-	
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =50V, V <sub>GS</sub> =0V, F=1MHz	-	10430	-	
Output Capacitance	Coss		-	1263	-	pF
Reverse Transfer Capacitance	Crss	]	-	35	-	
Gate Resistance	$R_g$	F=1MHz	-	2.2	-	Ω
Drain-Source Diode Characteristics	and Maximur	n Ratings		<u>.</u>		•
Continuous Source Current (Body Diode)	I <sub>S</sub>	MOSFET symbol showing the integral reverse p-n junction diode.	-	-	180	А
Pulsed Source Current (Body Diode)	I <sub>SM</sub>		-	-	720	Α
Diode Forward Voltage	VsD	V <sub>GS</sub> =0V, I <sub>S</sub> =90A	-	1	1.2	V
Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> =25°C, I <sub>F</sub> =90A,	-	85	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>	di/dt=100A/µs	-	0.26	-	uc

#### Note:

- 1. Pulse test: pulse width ≤ 300us, duty cycle ≤ 2%.
- 2. Repetitive rating: Pulsed width limited by maximum junction temperature.
- 3. L=0.5mH,  $V_{DD}$ =80V,  $I_{AS}$ =62A,  $T_{J}$ =25°C.
- 4. Device mounted on FR-4 PCB, 1 inch x 0.85 inch x 0.062 inch.



## **Typical Electrical and Thermal Characteristic Curves**

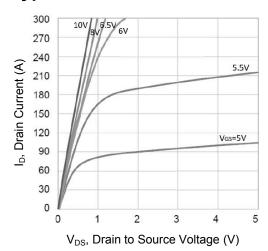


Figure 1. Typical Output Characteristics

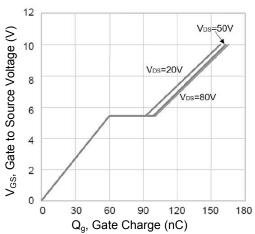


Figure 3. Gate Charge Characteristics

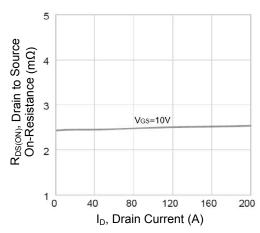


Figure 5. On Resistance vs. Drain Current

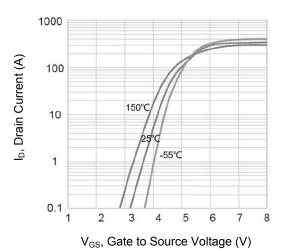


Figure 2. Typical Transfer Characteristics

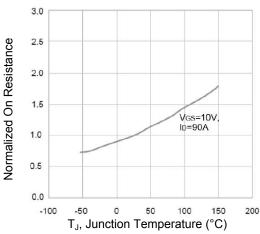


Figure 4. Normalized On-Resistance vs. Junction Temperature

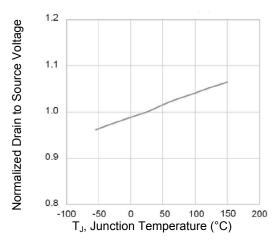


Figure 6. Normalized BV<sub>DSS</sub> vs. Junction Temperature



## **Typical Electrical and Thermal Characteristic Curves**

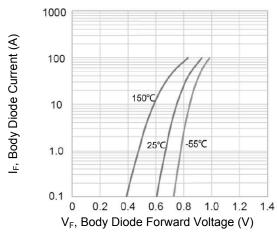


Figure 7. Body Diode Characteristics

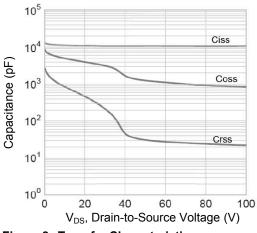


Figure 8. Transfer Characteristics

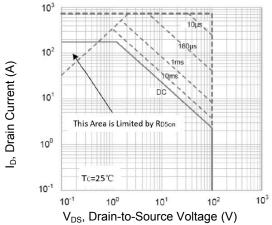
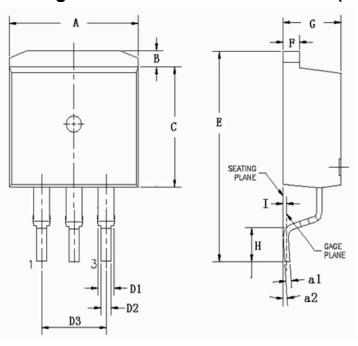


Figure 9. Safe Operation Area



## **100V N-Channel MOSFET**

# Package Outline Dimensions TO-263 (D<sup>2</sup>PAK)



Symbol	Dimesions in Millimeters		Dimensions in Inches		
	Min	Max	Min	Max	
А	9.660	10.280	0.380	0.405	
В	1.020	1.320	0.040	0.052	
С	8.590	9.400	0.339	0.370	
D1	1.140	1.400	0.045	0.055	
D2	0.700	0.900	0.028	0.037	
D3	5.080 TYP		0.200 TYP		
E	15.090	15.390	0.594	0.606	
F	1.150	1.400	0.045	0.055	
I	0.250 TYP		0.010 TYP		
G	4.300	4.700	0.169	0.185	
Н	2.290	2.790	0.090	0.110	
К	1.300	1.600	0.051	0.063	
a1	0.450	0.650	0.018	0.026	
a2	0°	8°	0°	8°	